

# Calendar of Meetings

## 1989

### **International Workshop on the Rietveld Method**

**June 13-15, 1989**

**Petten, The Netherlands**

Contact: Public Relations Office, Netherlands Energy Research Foundation ECN, P.O. Box 1, 1755 ZG Petten, The Netherlands. Sponsored by the International Union of Crystallography and organized by the Commission on Powder Diffraction in cooperation with the ECN, the emphasis of the meeting will be on the successes and the difficulties encountered in applying the Rietveld method to problems of current scientific interest and on the development of new techniques to improve the power, precision, and range of productive application of Rietveld refinement with both neutron and X-ray powder diffraction data.

### **Short Summer Course in X-Ray Powder Diffraction**

**June 16-23, 1989 Fundamentals**

**June 26-30, 1989 Advanced**

**State University of New York at Albany**

Contact: Professor Henry Chessin, State University of New York at Albany, Department of Physics, 1400 Washington Avenue, Albany, NY 12222 U.S.A. Phone (518) 442-4512. (Editor's Note: Each week is a separate course. The two weeks do not have to be taken in the same year.)

### **28th International Geological Congress**

**July 9-19, 1989**

**Washington, D.C., U.S.A.**

Contact: 28th International Geological Congress, P.O. Box 727, Tulsa, Oklahoma 74101, U.S.A.

### **American Crystallographic Association**

**Annual Meeting**

**July 23-28, 1989**

**Seattle, Washington**

Contact: American Crystallographic Association, 335 E. 45th Street, New York, NY 10017 U.S.A. Phone (212) 661-9404.

### **1989 Annual Denver Conference on Applications of**

**X-Ray Analysis**

**July 31-August 4, 1989**

**Denver, Colorado, U.S.A.**

Contact: Lynne Bonno, Conference Secretary, Dept. of Engineering, University of Denver, CO 80208, U.S.A. Phone (303) 871-3515. The subject of the Plenary Session will be "Application of X-Ray Methods to Thin Films." Also scheduled are sessions on Derivation of d-Values from Digitized Diffraction Patterns, Characterization and Analysis of Crystal Defects by XRD, Polymer Applications of XRD, XRF Techniques for Hazardous Wastes, and Other Applications of XRF. Also scheduled are Workshops on Calculation of XRD patterns, X-Ray Characterization of Epitaxial Thin Films, XRD Characterization of Polycrystalline Thin Films, XRD Characterization and Analysis of Lattice Defects, Maintenance and Optimum Use of Diffractometers, Derivation of D-Values from Digital XRD Patterns, XRF Sample Preparation, Quantitative XRF Software, and XRF Characterization of Thin Films.

### **12th European Crystallographic Meeting**

**August 20-29, 1989**

**Moscow, USSR**

Contact: ECM-12, Secretariat, c/o Institute of Crystallography, USSR Academy of Science, Leninsky pr. 59, Moscow 117333, USSR.

### **12th International Congress on X-Ray Optics and Microanalysis**

**August 28-September 1, 1989**

**Krakow, Poland**

Contact: 12 ICXOM, Institute of Metallurgy, Academy of Mining and Metallurgy, al Mickiewicza 30, 30-059 Krakow, Poland.

### **JCPDS—International Centre for Diffraction Data Fall Technical Meetings**

**October 25-26, 1989**

**Wilmington, Delaware**

Contact: Ms. Josephine Felizzi, JCPDS—International Centre for Diffraction Data, 1601 Park Lane, Swarthmore, PA 19081, U.S.A. Phone (215) 328-9403.

### **Geological Society of America**

**Annual Meeting and Geoscience Exposition**

**November 6-9, 1989**

**St. Louis, Missouri**

Contact: GSA Meeting Department, P.O. Box 9140, Boulder, CO 80301 U.S.A. Phone (303) 447-2020

### **Materials Research Society**

**Fall Meeting**

**November 27-December 2, 1989**

**Boston, Massachusetts**

Contact: M. Geil, Materials Research Society, 9800 McKnight Road, Suite 327, Pittsburgh, PA 15237 U.S.A. Phone (412) 367-3003.

## 1990

### **AXAA90 8th National Schools and Conference Meeting of Australian X-Ray Analytical Association**

**February 11-15, 1990**

**Melbourne, Australia**

Contact: Dr. John R. Davis, Convenor, AXAA90 (Vic Branch), P.O. Box 90, Parkville Vic 3052, Australia. ICDD Delegate, Dr. Allan Brown

### **International Union of Crystallography**

**15th General Assembly and International Congress**

**July 19-28, 1990**

**Bordeaux, France**

Contact: Prof. M. Hospital, Lab. de Cristallographie et de Physique Cristalline, Université de Bordeaux 1, 351 Cours de la Liberation, F 33405 Talence.

### **IMA 1990 — 15th General Meeting of International Mineralogical Association**

**June 28-July 3, 1990**

**Beijing, China**

Contact: Dr. Wang Zejiu, Chinese Academy of Geological Sciences, Baiwanzhuang Road 26, Fu Wai, Beijing, 100037, People's Republic of China.